

<b>Notice of References Cited</b>	Application/Control No. 10/541,940		Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Yaritza Guadalupe-McCall		Art Unit 2859	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,874,245	04-2005	Liu, Yu-Chun	33/758
*	B	US-6,839,981	01-2005	Rafter, William Michael	33/770
*	C	US-2003/0226274	12-2003	Lin, Henry	33/758
*	D	US-2004/0211080	10-2004	Lin, Henry	033/758
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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